

Shenzhen CTA Testing Technology Co., Ltd.

Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Bao'an District, Shenzhen, China

FCC PART 15 SUBPART C TEST REPORT

Report Reference No...... CTA23060700301

FCC ID.....: : 2AY5D-E6

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Date of issue......Jun. 16, 2023

Testing Laboratory Name Shenzhen CTA Testing Technology Co., Ltd.

Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community,

Fuhai Street, Bao'an District, Shenzhen, China

Applicant's name......Shenzhen USV Technology Co.,Ltd

. 4F, Building B20, Hengfeng Industrial City, Hangchen, Bao'an

District, Shenzhen City, Guangdong Province, China

Test specification:

FCC Rules and Regulations Part 15 Subpart C (Section 15.209),

ANSI C63.10: 2013

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Test item description Magnetic wireless charger

Trade MarkN/A

Manufacturer Shenzhen USV Technology Co.,Ltd

Model/Type reference..... E6

Listed ModelsA6, M6, Z6, C6

Modulation Type: ASK

Operation Frequency......From 110KHz~205KHz

Rating Input: 5V/9V

Wireless charge output: 5W/7.5W/10W/15W

Result.....: PASS

CTATEST

Shenzhen CTA Testing Technology Co., Ltd.

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TEST REPORT

Equipment under Test Magnetic wireless charger

Model /Type E6

Listed Models A6, M6, Z6, C6 CTATESTING

Applicant Shenzhen USV Technology Co.,Ltd

4F, Building B20, Hengfeng Industrial City, Hangchen, Bao'an Address

District, Shenzhen City, Guangdong Province, China

Manufacturer Shenzhen USV Technology Co.,Ltd

4F, Building B20, Hengfeng Industrial City, Hangchen, Bao'an Address

District, Shenzhen City, Guangdong Province, China

Test Result: **PASS**

The test report merely corresponds to the test sample.

It is not permitted to copy extracts of these test result without the written permission of the test laboratory.

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TEST STANDARDS

The tests were performed according to following standards:

FCC Rules and Regulations Part 15 Subpart C (Section 15.207): Conducted limits.

FCC Rules and Regulations Part 15 Subpart C (Section 15.207): Conducted limits. FCC Rules and Regulations Part 15 Subpart C (Section 15.209): Radiated emission limits; general requirements.

ANSI C63.10: 2013: American National Standard for Testing Unlicensed Wireless Devices

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SUMMARY

2.1 **General Remarks**

Date of receipt of test sample		Jun. 07, 2023
	V	
Testing commenced on	25	Jun. 07, 2023
Testing concluded on	:	Jun. 16, 2023

2.2 Product Description

Testing commenced on	: Jun. 07, 2023			
Testing concluded on	: Jun. 16, 2023			
2.2 Product Description				
Product Name:	Magnetic wireless charger			
Model/Type reference:	E6			
Hardware version:	V1.0			
Software version:	V1.0			
Test samples ID:	CTA230607003-1# (Engineer sample), CTA230607003-2# (Normal sample)			
Power supply:	Input: 5V/9V Wireless charge output: 5W/7.5W/10W/15W			
Adapter information (Auxiliary test supplied by test Lab):	Model: GS-551 Input: AC 100-240V 50/60Hz Output: DC 5V 3A, 9V 2A			
Operation frequency:	110KHz - 205KHz			
Modulation type:	ASK			
Antenna type:	Loop coil antenna			

2.3 Description of the test mode

Equipment under test was operated during the measurement under the following conditions:

☐ Charging and communication mode

Mode 1	Wireless Charging		Recorded
Mode 2	Standby	CIA	Pre-tested

2.4 **Special Accessories**

Follow auxiliary equipment(s) test with EUT that provided by the manufacturer or laboratory is listed as follow:

Description	Manufacturer	Model	Technical Parameters	Certificate	Provided by
	/	/	ING /	/	/

Modifications

No modifications were implemented to meet testing criteria.

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TEST ENVIRONMENT

Address of the test laboratory 3.1

Shenzhen CTA Testing Technology Co., Ltd.

Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Bao'an District, Shenzhen, China

3.2 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

FCC-Registration No.: 517856 Designation Number: CN1318

Shenzhen CTA Testing Technology Co., Ltd. has been listed on the US Federal Communications Commission list of test facilities recognized to perform electromagnetic emissions measurements.

A2LA-Lab Cert. No.: 6534.01

Shenzhen CTA Testing Technology Co., Ltd. has been listed by American Association for Laboratory Accreditation to perform electromagnetic emission measurement.

The 3m-Semi anechoic test site fulfils CISPR 16-1-4 according to ANSI C63.10 and CISPR 16-1-4:2010.

Environmental conditions

During the measurement the environmental conditions were within the listed ranges:

Radiated Emission:

Temperature:	24 ° C
Table 1	
Humidity:	45 %
	The state of the s
Atmospheric pressure:	950-1050mbar

AC Power Conducted Emission:

TO I OWEL COLLUCIED ETHISSION.	
Temperature:	25 ° C
INC	
Humidity:	46 %
TIN	5
Atmospheric pressure:	950-1050mbar

Conducted testing:

Atmospheric pressure:	950-1050mbar	·G
Conducted testing:		ESTING
Temperature:	25 ° C	CATE
	C	1
Humidity:	44 %	
	7.3 waster	
Atmospheric pressure:	950-1050mbar	

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Summary of measurement results

Description of test	Result	
Conducted emissions test	Compliant	
Radiated emission test	Compliant	
The 20dB bandwidth measurement	Compliant	
Antenna requirement	Compliant	

3.5 Statement of the measurement uncertainty

The data and results referenced in this document are true and accurate. The reader is cautioned that there may be errors within the calibration limits of the equipment and facilities. The measurement uncertainty was calculated for all measurements listed in this test report acc. to CISPR 16 - 4 "Specification for radio disturbance and immunity measuring apparatus and methods - Part 4: Uncertainty in EMC Measurements" and is documented in the Shenzhen CTA Testing Technology Co., Ltd. quality system acc. to DIN EN ISO/IEC 17025. Furthermore, component and process variability of devices similar to that tested may result in additional deviation. The manufacturer has the sole responsibility of continued compliance of

Hereafter the best measurement capability for Shenzhen CTA laboratory is reported:

Test	Range	Measurement Uncertainty	Notes
Radiated Emission	30~1000MHz	4.06 dB	(1)
Radiated Emission	1~18GHz	5.14 dB	(1)
Radiated Emission	18-40GHz	5.38 dB	(1)
Conducted Disturbance	0.15~30MHz	2.14 dB	(1)

⁽¹⁾ This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2. CTATES

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Equipments Used during the Test 3.6

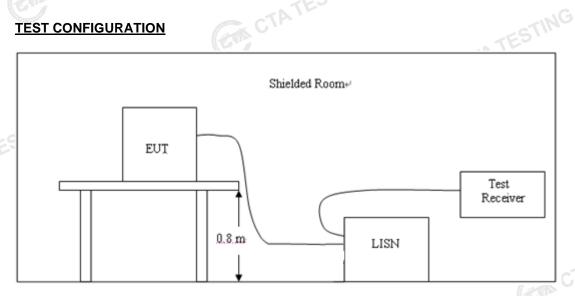
	Test Equipment	Manufacturer	Model No.	Equipment No.	Calibration Date	Calibration Due Date
	LISN	R&S	ENV216	CTA-308	2022/08/03	2023/08/02
	LISN	R&S	ENV216	CTA-314	2022/08/03	2023/08/02
	EMI Test Receiver	R&S	ESPI	CTA-307	2022/08/03	2023/08/02
	EMI Test Receiver	R&S	ESCI	CTA-306	2022/08/03	2023/08/02
CTATE	Spectrum Analyzer	Agilent	N9020A	CTA-301	2022/08/03	2023/08/02
Cv	Spectrum Analyzer	R&S	FSP	CTA-337	2022/08/03	2023/08/02
	Vector Signal generator	Agilent	N5182A	CTA-305	2022/08/03	2023/08/02
	Analog Signal Generator	R&S	SML03	CTA-304	2022/08/03	2023/08/02
	Universal Radio Communication	CMW500	R&S	CTA-302	2022/08/03	2023/08/02
G	Temperature and humidity meter	Chigo	ZG-7020	CTA-326	2022/08/03	2023/08/02
	Ultra-Broadband Antenna	Schwarzbeck	VULB9163	CTA-310	2021/08/07	2024/08/06
	Horn Antenna	Schwarzbeck	BBHA 9120D	CTA-309	2021/08/07	2024/08/06
	Loop Antenna	Zhinan	ZN30900C	CTA-311	2021/08/07	2024/08/06
	Horn Antenna	Beijing Hangwei Dayang	OBH100400	CTA-336	2021/08/07	2024/08/06
	Amplifier	Schwarzbeck	BBV 9745	CTA-312	2022/08/03	2023/08/02
	Amplifier	Taiwan chengyi	EMC051845B	CTA-313	2022/08/03	2023/08/02
	Directional coupler	NARDA	4226-10	CTA-303	2022/08/03	2023/08/02
	High-Pass Filter	XingBo	XBLBQ-GTA18	CTA-402	2022/08/03	2023/08/02
TE	High-Pass Filter	XingBo	XBLBQ-GTA27	CTA-403	2022/08/03	2023/08/02
CTA	Automated filter bank	Tonscend	JS0806-F	CTA-404	2022/08/03	2023/08/02
	Power Sensor	Agilent	U2021XA	CTA-405	2022/08/03	2023/08/02
	Amplifier	Schwarzbeck	BBV9719	CTA-406	2022/08/03	2023/08/02
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TEST CONDITIONS AND RESULTS

4.1 AC Power Conducted Emission

TEST CONFIGURATION



TEST PROCEDURE

- 1, The equipment was set up as per the test configuration to simulate typical actual usage per the user's manual. The EUT is a tabletop system, a wooden table with a height of 0.8 meters is used and is placed on the ground plane as per ANSI C63.10.
- 2, Support equipment, if needed, was placed as per ANSI C63.10.
- 3, All I/O cables were positioned to simulate typical actual usage as per ANSI C63.10.
- 4, If a EUT received DC power from the USB Port of Notebook PC, the PC's adapter received power through a Line Impedance Stabilization Network (LISN) which supplied power source and was grounded to the ground plane.
- 5, All support equipments received AC power from a second LISN, if any.
- 6, The EUT test program was started. Emissions were measured on each current carrying line of the EUT using a spectrum Analyzer / Receiver connected to the LISN powering the EUT. The LISN has two monitoring points: Line 1 (Hot Side) and Line 2 (Neutral Side). Two scans were taken: one with Line 1 connected to Analyzer / Receiver and Line 2 connected to a 50 ohm load; the second scan had Line 1 connected to a 50 ohm load and Line 2 connected to the Analyzer / Receiver.
- 7, Analyzer / Receiver scanned from 150 KHz to 30MHz for emissions in each of the test modes.

AC Power Conducted Emission Limit

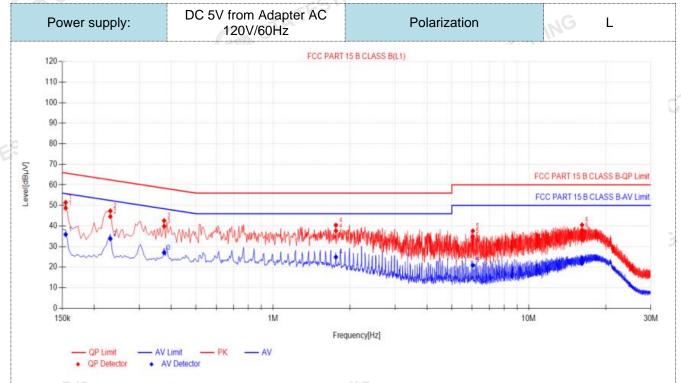
For intentional device, according to § 15.207(a) AC Power Conducted Emission Limits is as following:

Eroquonov rongo (MHz)	Limit (dBuV)		
Frequency range (MHz)	Quasi-peak	Average	
0.15-0.5	66 to 56*	56 to 46*	
0.5-5	56	46	
5-30	60	50	
* Decreases with the logarithm of the frequ	ency.		
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TEST RESULTS

1. Both 120 VAC, 50/60 Hz and 240 VAC, 50/60 Hz power supply have been tested, only the worst result of 120 VAC, 60 Hz was reported as below:



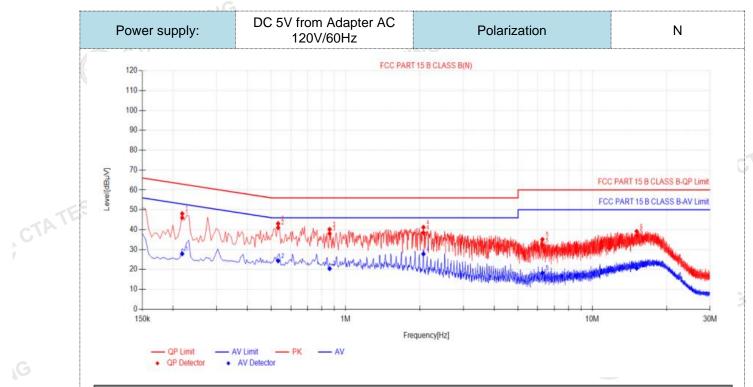
Final	Final Data List												
NO.	Freq. [MHz]	Factor [dB]	QP Reading[dB μV]	QP Value [dΒμV]	QP Limit [dΒμV]	QP Margin [dB]	AV Reading [dBµV]	AV Value [dΒμV]	AV Limit [dΒμV]	AV Margin [dB]	Verdict		
1	0.1545	10.50	38.23	48.73	65.75	17.02	25.39	35.89	55.75	19.86	PASS		
2	0.231	10.50	34.12	44.62	62.41	17.79	23.35	33.85	52.41	18.56	PASS		
3	0.375	10.50	29.39	39.89	58.39	18.50	16.56	27.06	48.39	21.33	PASS		
4	1.761	10.50	27.18	37.68	56.00	18.32	14.40	24.90	46.00	21.10	PASS		
5	6.045	10.50	24.44	34.94	60.00	25.06	10.39	20.89	50.00	29.11	PASS		
6	16.161	10.50	27.25	37.75	60.00	22.25	11.42	21.92	50.00	28.08	PASS		

Note: Note:1).QP Value ($dB\mu V$)= QP Reading ($dB\mu V$)+ Factor (dB)

- 2). Factor (dB)=insertion loss of LISN (dB) + Cable loss (dB)
- 3). QPMargin(dB) = QP Limit (dB μ V) QP Value (dB μ V)
- 4). AVMargin(dB) = AV Limit (dB μ V) AV Value (dB μ V)

GM CTATESTING

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Final Data List													
Freq. [MHz]	Factor [dB]	QP Reading[dB μV]	QP Value [dBµV]	QP Limit [dΒμV]	QP Margin [dB]	AV Reading [dBμV]	AV Value [dΒμV]	AV Limit [dΒμV]	AV Margin [dB]	Verdict			
0.2175	10.50	35.49	45.99	62.91	16.92	17.33	27.83	52.91	25.08	PASS			
0.5325	10.50	30.49	40.99	56.00	15.01	13.80	24.30	46.00	21.70	PASS			
0.861	10.50	27.57	38.07	56.00	17.93	9.90	20.40	46.00	25.60	PASS			
2.067	10.50	27.99	38.49	56.00	17.51	17.27	27.77	46.00	18.23	PASS			
6.279	10.50	21.63	32.13	60.00	27.87	7.67	18.17	50.00	31.83	PASS			
15.126	10.50	26.54	37.04	60.00	22.96	10.07	20.57	50.00	29.43	PASS			
6													
	Freq. [MHz] 0.2175 0.5325 0.861 2.067 6.279 15.126 lote:1).QP	Freq. [MHz] Factor [dB] 0.2175 10.50 0.5325 10.50 0.861 10.50 2.067 10.50 6.279 10.50 15.126 10.50 lote:1).QP Value (constraint)	Freq. [MHz] Factor [dB] PReading[dB μV] 0.2175 10.50 35.49 0.5325 10.50 30.49 0.861 10.50 27.57 2.067 10.50 27.99 6.279 10.50 21.63 15.126 10.50 26.54 Iote:1).QP Value (dBμV)= C	Freq. [MHz] Factor [dB] Peading[dB μV] Value [dBμV] 0.2175 10.50 35.49 45.99 0.5325 10.50 30.49 40.99 0.861 10.50 27.57 38.07 2.067 10.50 27.99 38.49 6.279 10.50 21.63 32.13 15.126 10.50 26.54 37.04 Iote:1).QP Value (dBμV)= QP Reading QP Read	Freq. [MHz] Factor [dB] Reading[dB Value [dBμV] [dBμV] 0.2175 10.50 35.49 45.99 62.91 0.5325 10.50 30.49 40.99 56.00 0.861 10.50 27.57 38.07 56.00 2.067 10.50 27.99 38.49 56.00 6.279 10.50 21.63 32.13 60.00 15.126 10.50 26.54 37.04 60.00 Iote:1).QP Value (dBμV)= QP Reading (dBμ)	$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$	$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$	Freq. [MHz] Factor [dB] Reading[dB μV] Limit [dB μV] 25.08 0.5325 10.50 30.49 40.99 56.00 15.01 13.80 24.30 46.00 21.70 0.861 10.50 27.57 38.07 56.00 17.93 9.90 20.40 46.00 25.60 2.067 10.50 27.99 38.49 56.00 17.51 17.27 27.77 46.00 18.23 6.279 10.50 21.63 32.13 60.00 27.87 7.67 18.17 50.00 31.83 15.126 10.50 26.54 37.04 60.00 22.96 10.07 20.57 50.00 29.43 Note:1).QP Value (dB μV)= QP Reading (dB μV)+ Factor (dB)	$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$		

CTA TESTING

- 2). Factor (dB)=insertion loss of LISN (dB) + Cable loss (dB)
- 3). QPMargin(dB) = QP Limit (dB μ V) QP Value (dB μ V)
- 4). $AVMargin(dB) = AV Limit (dB\mu V) AV Value (dB\mu V)$

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4.2 **Radiated Emission**

Limit

For intentional device, according to § 15.209(a), the general requirement of field strength of radiated emission out of authorized band shall not exceed the following table at a 3 meters measurement distance.

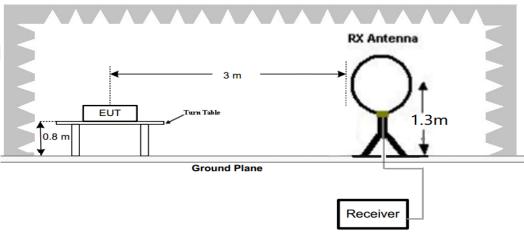
In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in §15.209(a)

Radiated	

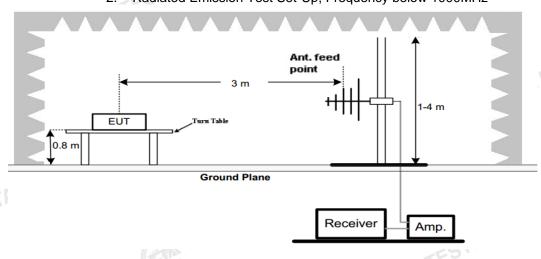
	Frequency (MHz)	Distance (Meters)	Radiated (dBµV/m)	Radiated (µV/m)
	0.009-0.49	3	20log(2400/F(KHz))+40log(300/3)	2400/F(KHz)
CTATE	0.49-1.705	3	20log(24000/F(KHz))+ 40log(30/3)	24000/F(KHz)
CAL	1.705-30	3	20log(30)+ 40log(30/3)	30
1	30-88	3	40.0	100
	88-216	3	43.5	150
	216-960	3	46.0	200
	Above 960	3	54.0	500

TEST CONFIGURATION

Radiated Emission Test Set-Up, Frequency Below 30MHz



Radiated Emission Test Set-Up, Frequency below 1000MHz



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- Below 1GHz measurement the EUT is placed on a turntable which is 0.8m above ground plane.
- Maximum procedure was performed by raising the receiving antenna from 1m to 4m and rotating the turn table from 0°C to 360°C to acquire the highest emissions from EUT
- 3. And also, each emission was to be maximized by changing the polarization of receiving antenna both horizontal and vertical.
- Repeat above procedures until all frequency measurements have been completed. 4.
- 5. Radiated emission test frequency band from 9KHz to 1000MHz.
- The distance between test antenna and EUT as following table states: 6.

Test Frequency range	Test Antenna Type	Test Distance							
9KHz-30MHz	Active Loop Antenna	3							
30MHz-1GHz	Bilog Antenna	3							

Setting test receiver/spectrum as following table states:

Test Frequency range	Test Receiver/Spectrum Setting	Detector					
9KHz-150KHz	RBW=200Hz/VBW=3KHz,Sweep time=Auto	QP					
150KHz-30MHz	RBW=9KHz/VBW=100KHz,Sweep time=Auto	QP					
30MHz-1GHz	RBW=120KHz/VBW=1000KHz,Sweep time=Auto	QP					
RESULTS	GTA TES	CTATE					
Hz-30MHz							
WOR	ST-CASE RADIATED EMISSION BELOW 30 MHz						

TEST RESULTS

For 9 KHz-30MHz

WORST-CASE RADIATED EMISSION BELOW 30 MHz

Frequency	Reading	Polar	Antenna Factor	Cable Loss	Emission Levels	Limits at 3m	Margin	Detector Mode
(MHz)	(dBµV/m)	Loop	(dB/m)	(dB)	(dBµV/m)	(dBµV/m)	(dB)	
0.136000(F)	76.37	Loop	23.63	0.02	100.02	104.93	4.91	PK
0.136000(F)	53.78	Loop	23.63	0.02	77.43	84.93	7.50	AV
0.110	52.32	Loop	23.51	0.02	75.85	106.78	30.93	PK
0.110	48.44	Loop	23.51	0.02	71.97	86.78	14.81	AV
0.288	43.66	Loop	23.82	-0.17	67.31	98.42	31.11	QP
0.471	40.33	Loop	24.21	-0.28	64.26	94.14	29.88	QP
0.549	33.66	Loop	24.32	-0.3	57.68	72.81	15.13	QP
(3								W

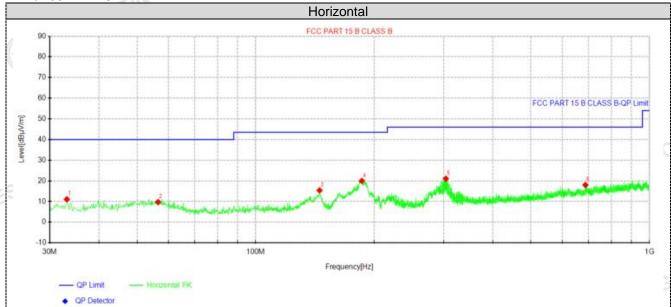
Remark:

- Data of measurement within this frequency range shown "-- in the table above means the reading of emissions are attenuated more than 20dB below the permissible limits and not recorded.
- 2. The test limit distance is 3m limit.
- PK means Peak Value, QP means Quasi Peak Value, AV means Average Value.
- 4. F means Fundamental Frequency.
- 5. Emission level (dBuV/m) = Reading + Antenna Factor + Cable Loss.
- Margin value = Limit value- Emission level.

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For 30MHz-1GHz

CTATESTING

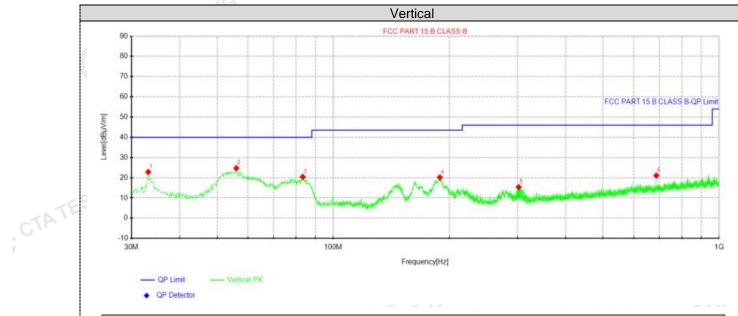


Suspe	Suspected Data List												
NO	Freq.	Reading	Level	Factor	Limit	Margin	Height	Angle	Dolorita				
NO.	[MHz]	[dBµV]	[dBµV/m]	[dB/m]	[dBµV/m]	[dB]	[cm]	[°]	Polarity				
1	33.1525	29.24	11.06	-18.18	40.00	28.94	100	0	Horizontal				
2	56.5538	27.21	9.74	-17.47	40.00	30.26	100	214	Horizontal				
3	145.308	37.16	15.39	-21.77	43.50	28.11	100	188	Horizontal				
4	186.048	40.13	19.97	-20.16	43.50	23.53	100	53	Horizontal				
5	304.025	38.34	21.05	-17.29	46.00	24.95	100	180	Horizontal				
6	687.538	29.73	17.99	-11.74	46.00	28.01	100	231	Horizontal				

CIA

Note:1).Level $(dB\mu V/m)$ = Reading $(dB\mu V)$ + Factor (dB/m)

- 2). Factor(dB/m)=Antenna Factor (dB/m) + Cable loss (dB) Pre Amplifier gain (dB)
- 3). Margin(dB) = Limit (dB μ V/m) Level (dB μ V/m)



Suspe	Suspected Data List												
NO	Freq.	Reading	Level	Factor	Limit	Margin	Height	Angle	Dolorita				
NO.	[MHz]	[dBµV]	[dBµV/m]	[dB/m]	[dBµV/m]	[dB]	[cm]	[°]	Polarity				
1	33.1525	40.97	22.79	-18.18	40.00	17.21	100	323	Vertical				
2	56.0688	42.03	24.67	-17.36	40.00	15.33	100	3	Vertical				
3	83.35	41.25	20.39	-20.86	40.00	19.61	100	360	Vertical				
4	188.958	40.12	20.14	-19.98	43.50	23.36	100	323	Vertical				
5	302.327	32.64	15.33	-17.31	46.00	30.67	100	360	Vertical				
6	687.538	32.80	21.06	-11.74	46.00	24.94	100	180	Vertical				

Note:1).Level ($dB\mu V/m$)= Reading ($dB\mu V$)+ Factor (dB/m)

- 2). Factor(dB/m)=Antenna Factor (dB/m) + Cable loss (dB) Pre Amplifier gain (dB)
- 3). Margin(dB) = Limit (dB μ V/m) Level (dB μ V/m)

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4.3 The 20dB bandwidth

TEST CONFIGURATION



TEST PROCEDURE

Intentional radiators operating under the alternative provisions to the general emission limits, as contained in §§15.217 through 15.257 and in subpart E of this part, must be designed to ensure that 20dB bandwidth of the emission, or whatever bandwidth may otherwise be specified in the specific rule section under which the equip compliance with the 20dB attenuation specification may base on measurement at the intentional radiator's antenna output terminal unless the intentional radiator uses a permanently attached antenna, in which case compliance shall be deomonstrated by measuring the radiated emissions.

LIMIT

The 20dB bandwidth shall be less than 80% of the permitted frequency band.

TEST RESULTS

Mode	Freq (KHz)	20dB Bandwidth (KHz)	Conclusion
Tx Mode	136.00	33.29	PASS



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Antenna Requirement

Standard Applicable

Standard Applicable

CTA TESTING For intentional device, according to FCC 47 CFR Section 15.203, an intentional radiator shall be designed to CTATE ensure that no antenna other than that furnished by the responsible party shall be used with the device.

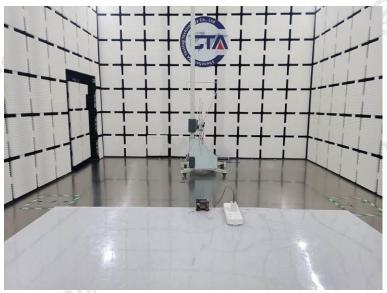
Antenna Information

The antenna used in this product is a Coil Antenna, The directional gains of antenna used for transmitting is CTATES 0dBi.

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Test Setup Photos of the EUT







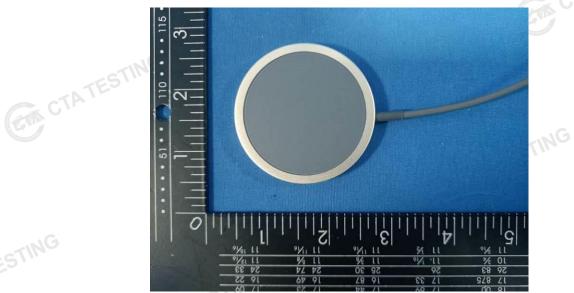
Shenzhen CTA Testing Technology Co., Ltd.

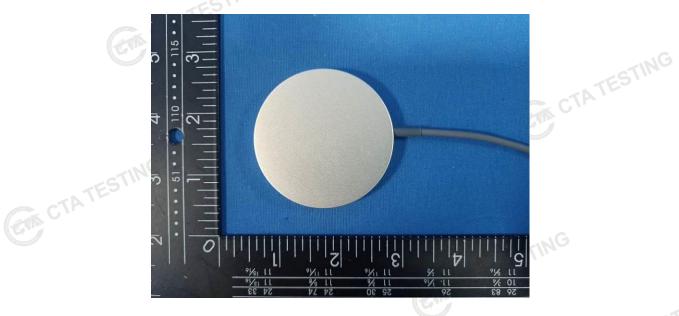
Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Bao'an District, Shenzhen, China Tel:+86-755 2322 5875 E-mail:cta@cta-test.cn Web:http://www.cta-test.cn

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PHOTOS OF THE EUT



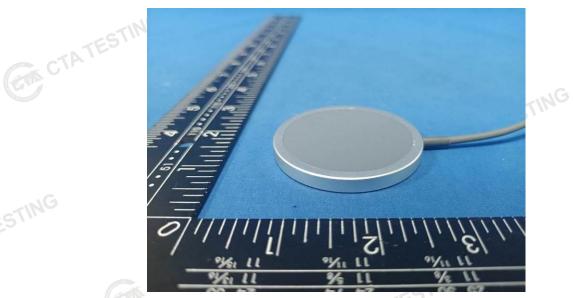


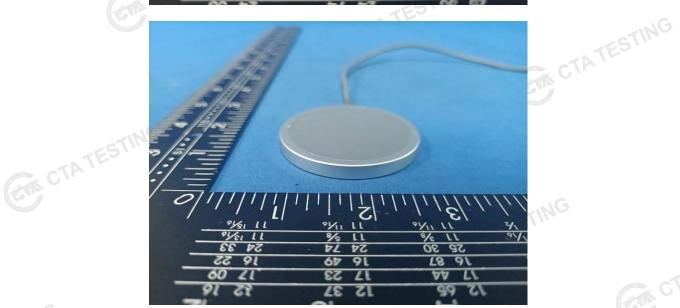


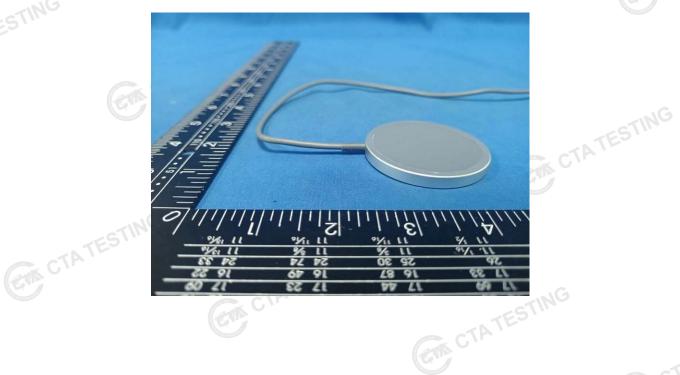
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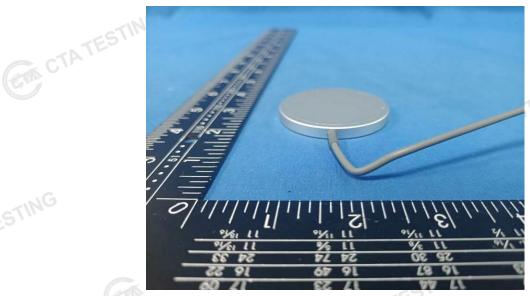




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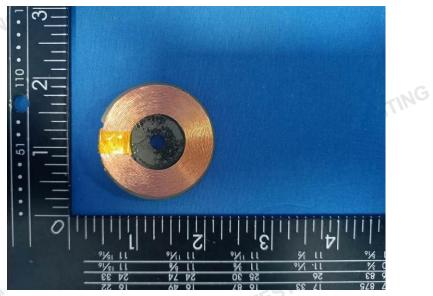


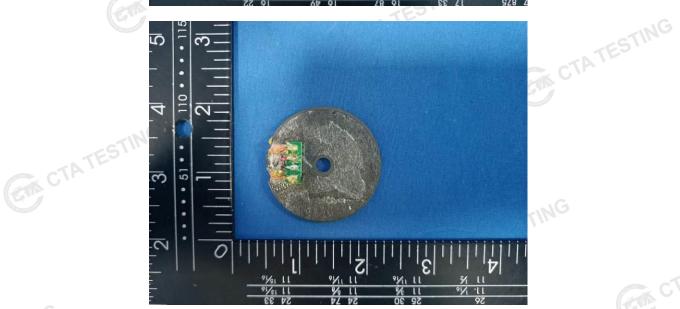


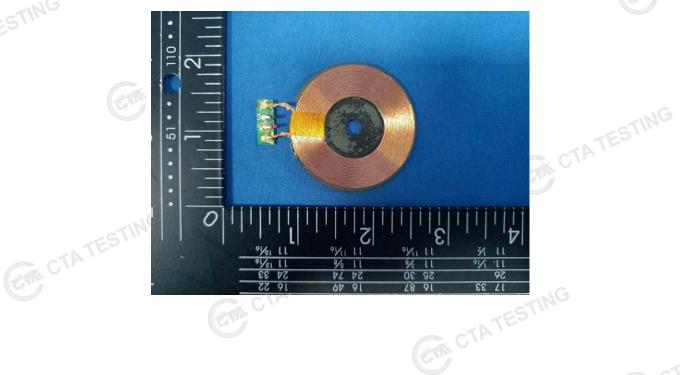


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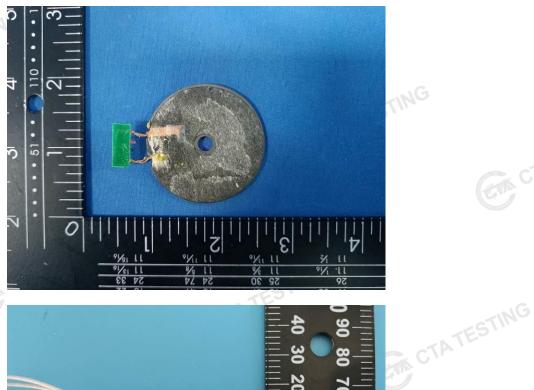


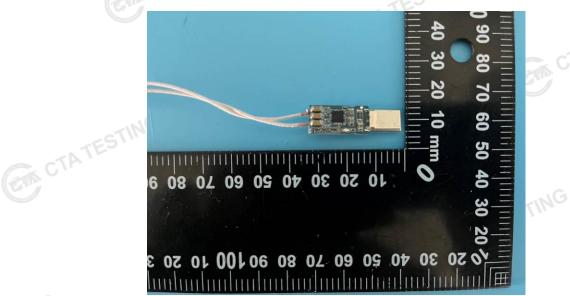


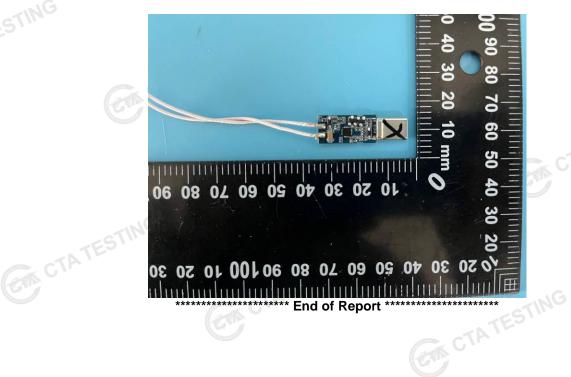
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